

Laser Processing of Materials

Ablation Model

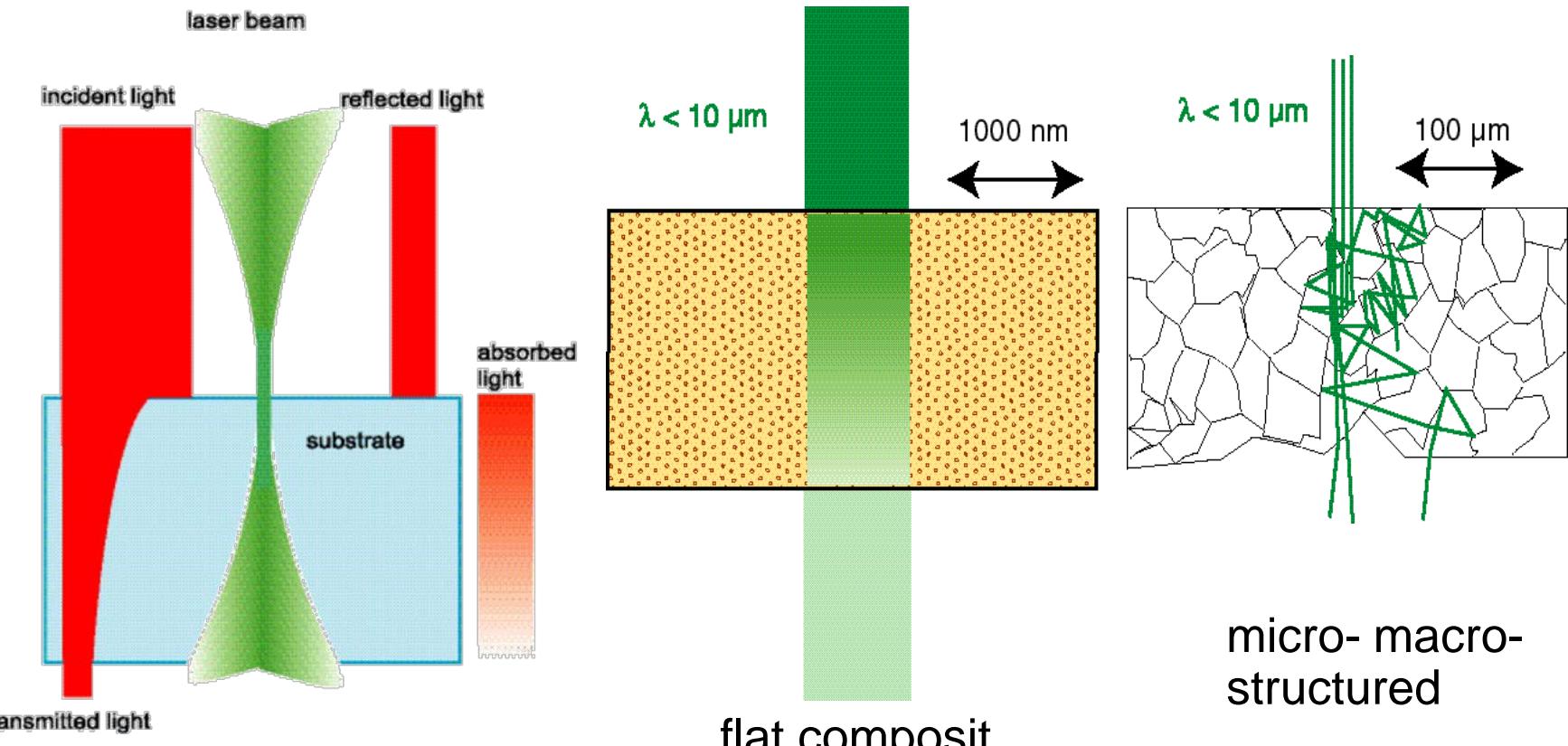
Patrik Hoffmann

UV- Excimer Laser Ablation

- Model
- Influences
- Examples
- Applications

D. Bäuerle; Laser Processing and Chemistry,
3rd Edititon, Springer Berlin, 2000

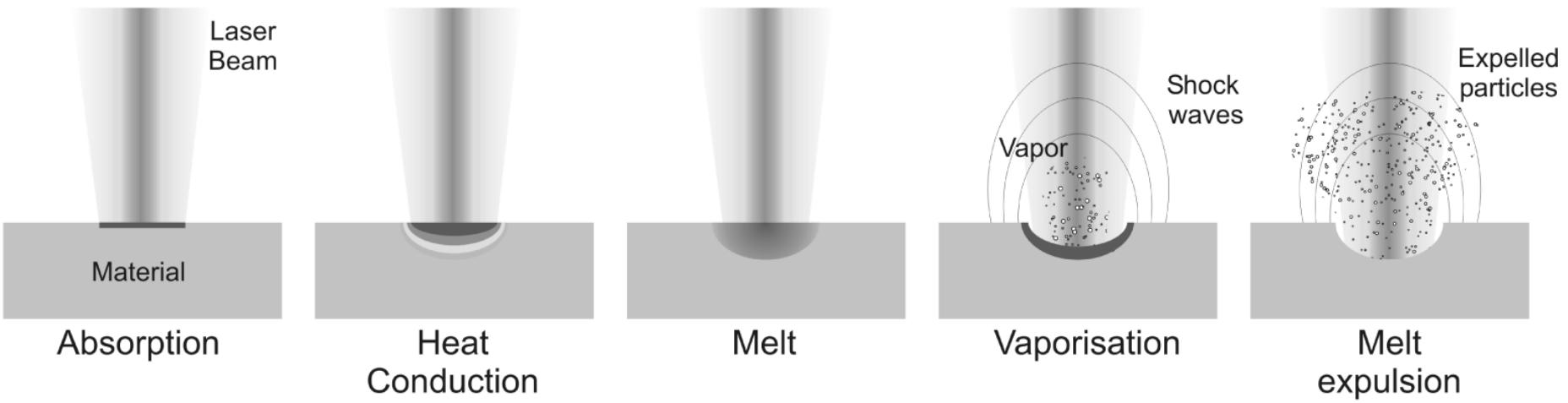
Laser light material interaction



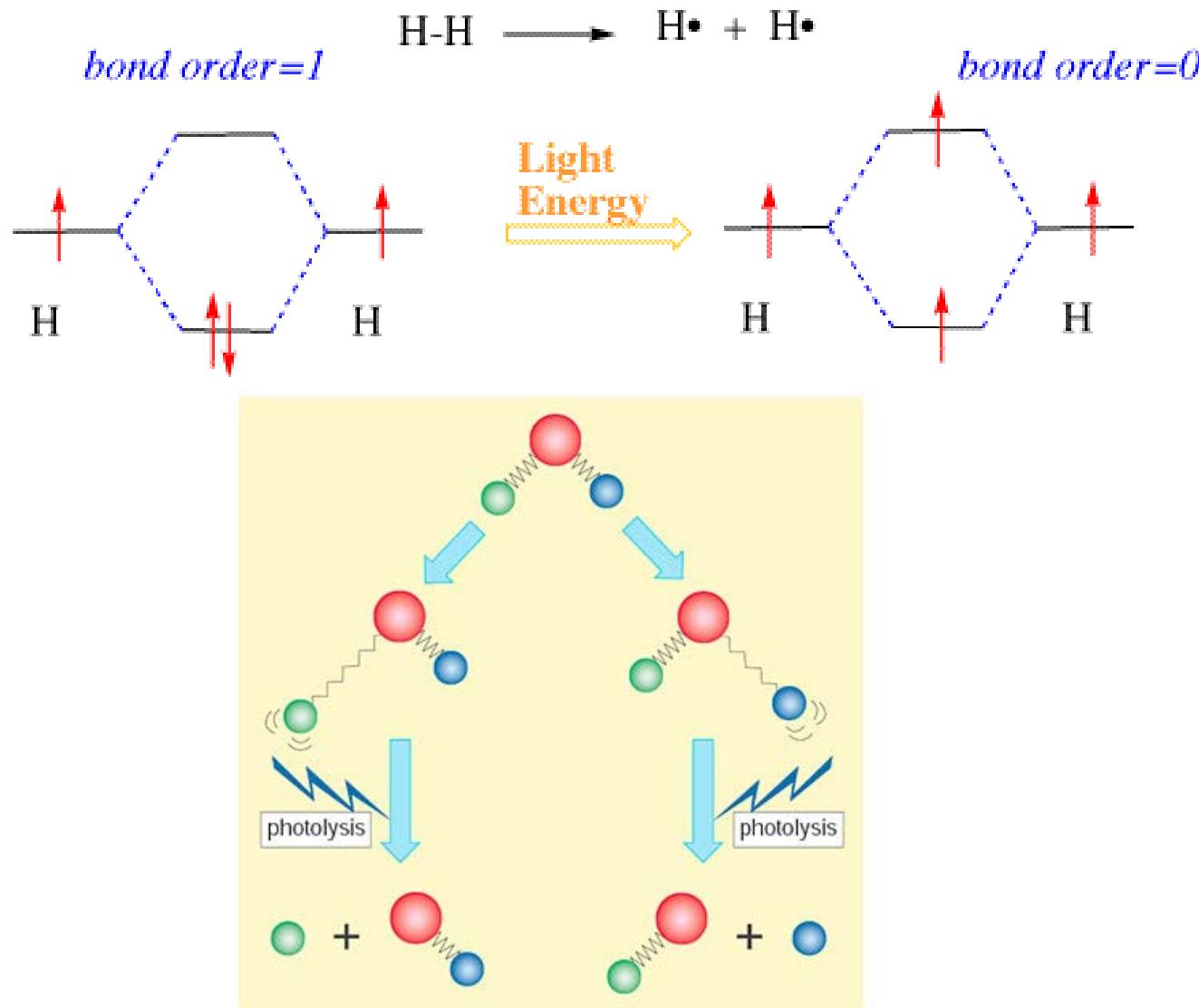
- Flat homogeneous

How is rough homogeneous ?

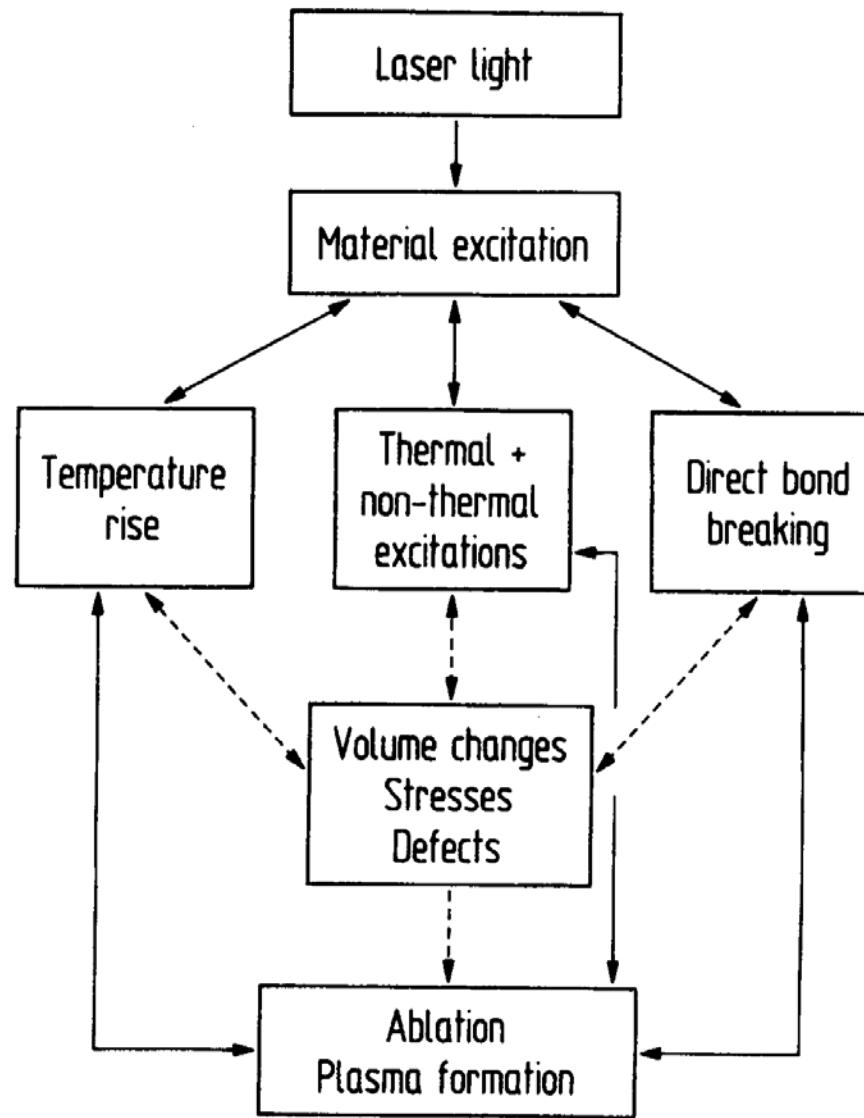
Thermal Influence



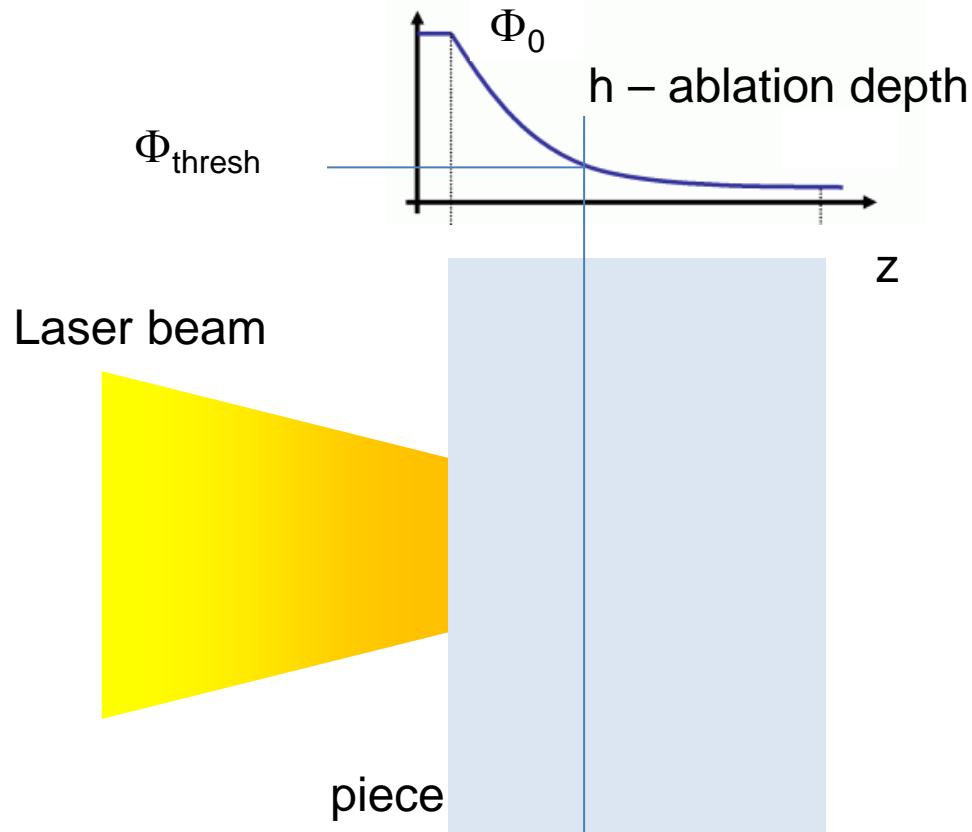
Photolysis – Direct Bond Breaking



Ablation model



Ablation Depth



Physical Model

$$\Phi(d) = \Phi_{\text{exp}}^{-\alpha_{\text{eff}} \cdot d}$$

Lambert-Beer's absorption law

$$\Phi_{\Delta h} = \Phi_{\text{thresh}} = \Phi_0^{-\alpha_{\text{eff}} \cdot \Delta h}$$

threshold fluence is still reached at Δh depth

$$\Delta h(\Phi) = l_{\alpha_{\text{eff}}} \ln \Phi - l_{\alpha_{\text{eff}}} \ln \Phi_{\text{thresh.}}$$

ablation rate vs. fluence dependance

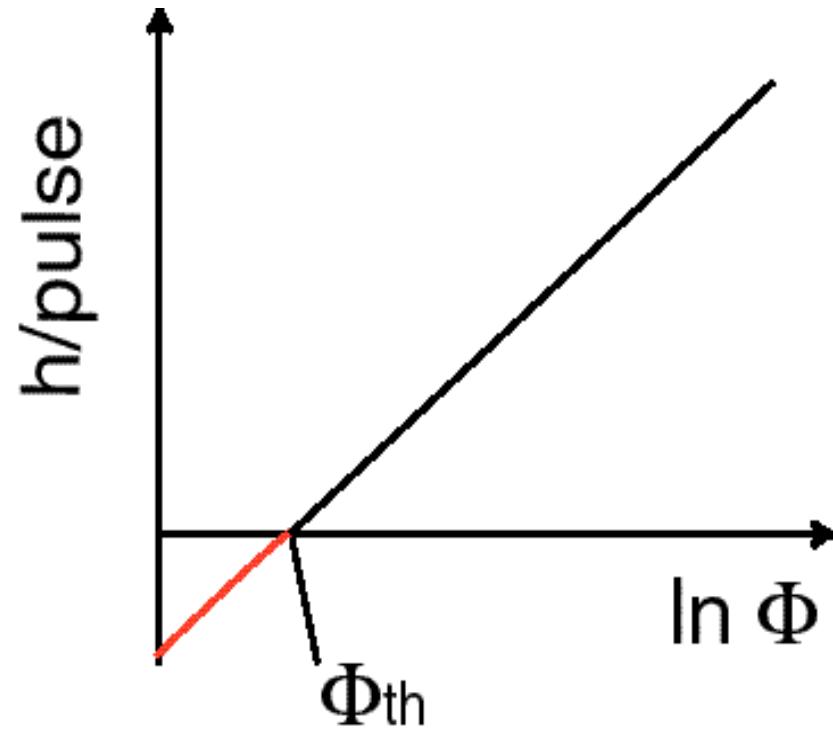
Effective Absorption Coefficient

$$\alpha_{\text{eff}} = \alpha_0 + \sigma_D N_D + \alpha_i(N) + \alpha^{NL}$$

α_0 = linear absorption coefficient

σ_D = Dopant cross section

Limits: no sense at extremely high laser powers, avalanche ionization



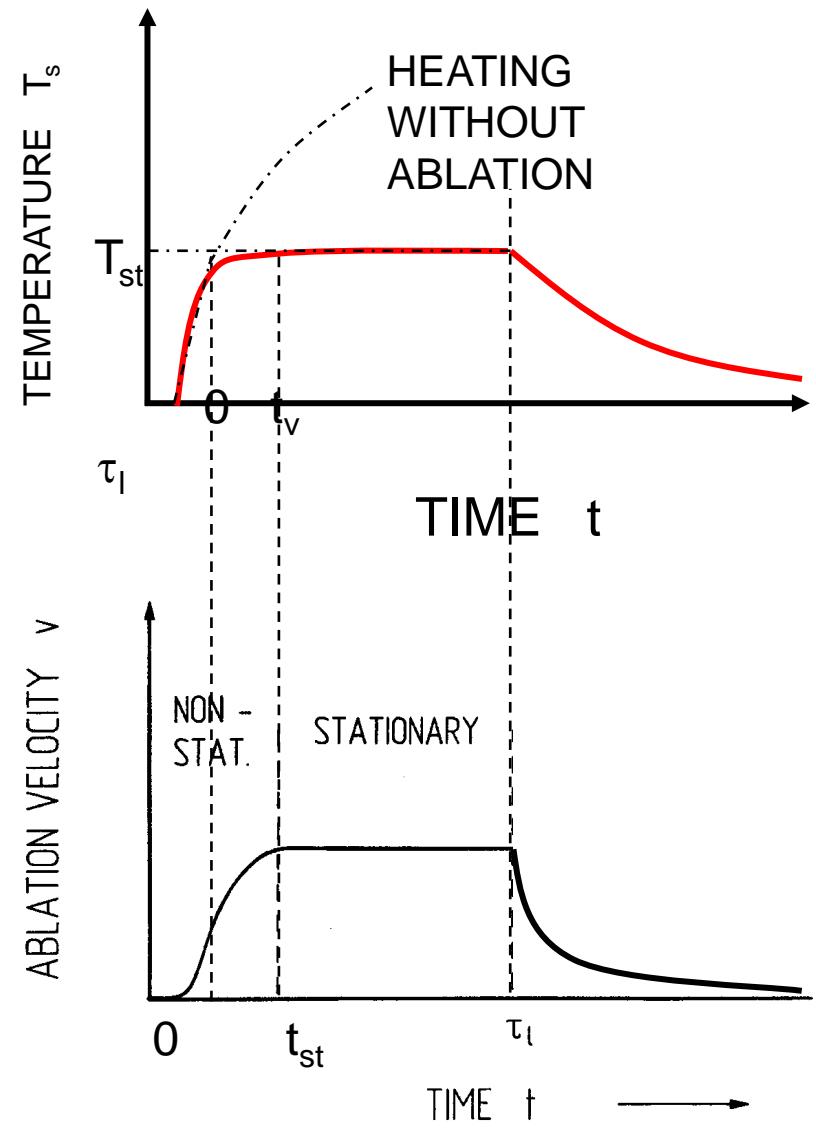
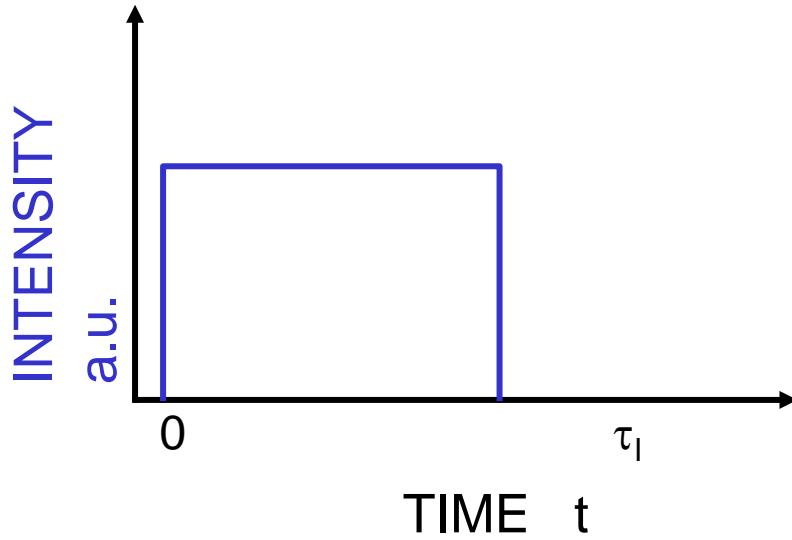
Single Pulse Ablation

Photothermal ablation

$\tau_T \ll \tau_{des}$ pure thermal ablation, IR, vis and many UV

Assumptions:

- homogeneous irradiation
- $w \gg l_{th}, l_\alpha$
- no stress
- no T dependence



Single pulse ablation

- Influence of pulse duration

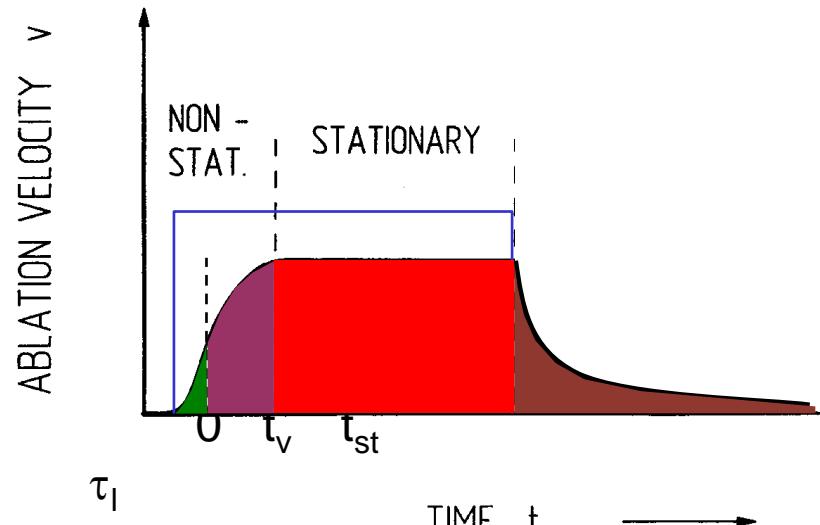
$$\Delta h = \int_0^\infty v(t)dt \approx \Delta h_1 + \Delta h_2 + \Delta h_3 + \Delta h_4$$

$$\Delta h_1 \equiv \Delta h_1(t \leq t_v)$$

$$\Delta h_2 \equiv \Delta h_2(t_v \leq t \leq t_{st})$$

$$\Delta h_3 \equiv \Delta h_3(t_{st} \leq t \leq \tau_l)$$

$$\Delta h_4 \equiv \Delta h_4(t \geq \tau_l)$$



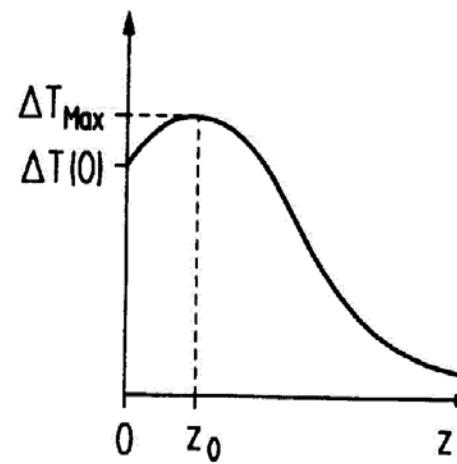
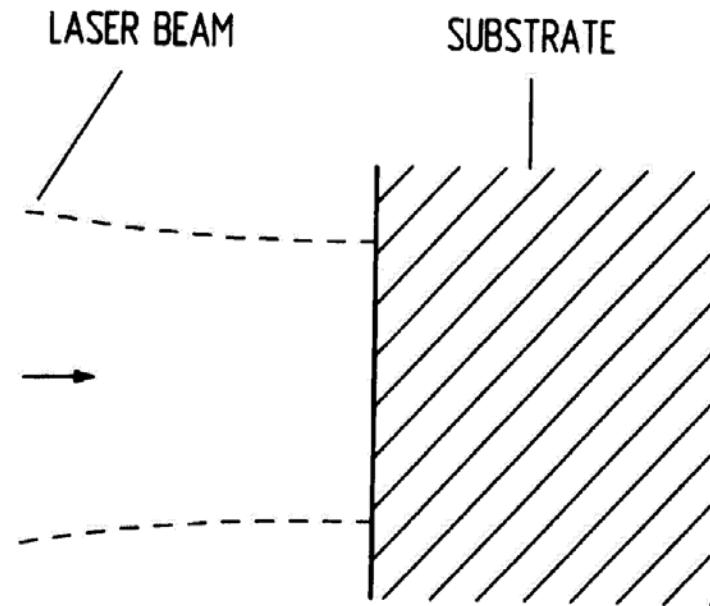
Δh_1 to be ignored in all cases

fs, ps ablation Δh_4

μs, ms ablation Δh_3

ns ablation $\Delta h_2, \Delta h_3, \Delta h_4$

Pulsed Laser Ablation



Interaction 193 nm Excimer light with materials

- Optical penetration depth:

$$l_\alpha = \frac{1}{\alpha}$$

- Thermal penetration depth:

$$l_{th} = 2\sqrt{D\tau_l}$$

	l_α	l_{th}
Al	10 nm	2.80 μm
Mo	< 30 nm	2.04 μm
SiO_2	3.3 m	270 nm
PET	30 nm	90 nm

α : optical absorption coefficient
[cm^{-1}]

D: thermal diffusivity [cm^2 / s]

τ_l : pulse duration

Pulsed Laser Ablation (PLA)

- How much material is taken off per laser pulse ?

$$\Delta h \approx \max(l_{th}, l_{\alpha})$$

What are the physical steps ?

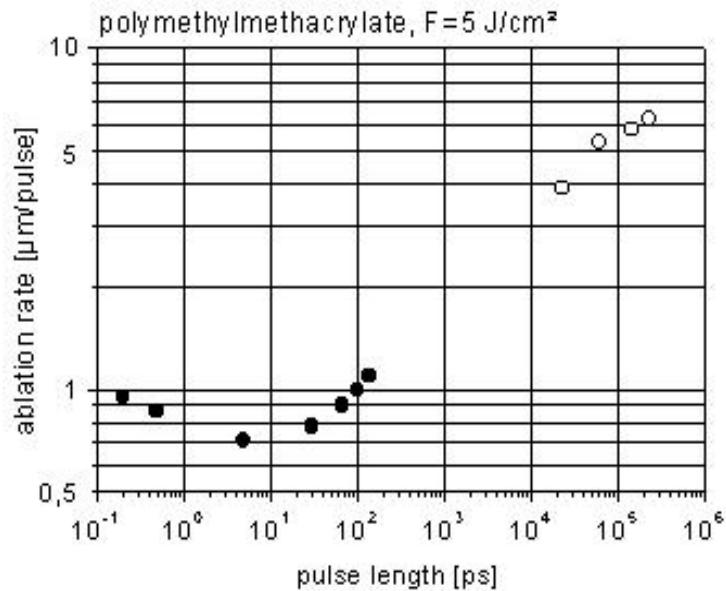
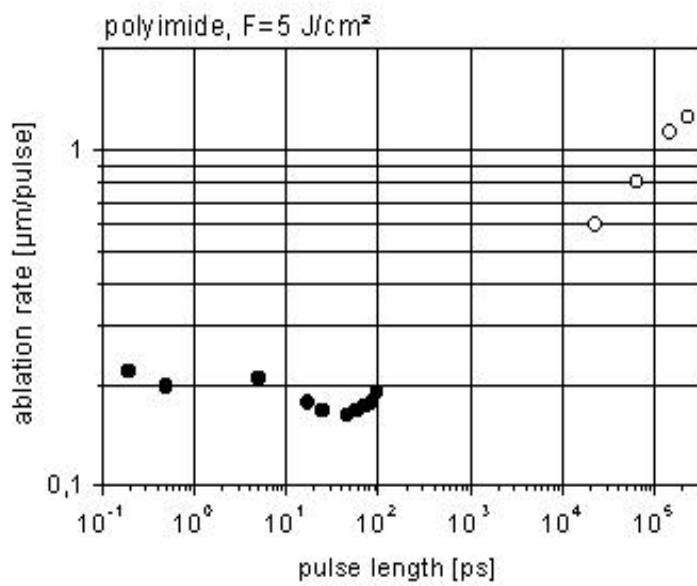
Optical absorption

Energy dissipation

Decomposition

Material removal

Ablation rate dependance: Pulse duration



Conclusions

Ablation Process characteristics

threshold value for Laser light fluence ϕ_{th}

$$\phi_{th_{oxides}} = 0.5 - 2 \text{ [J/cm}^2\text{]}$$

$$\phi_{th_{polymers}} = 0.01 - 1 \text{ [J/cm}^2\text{]}$$

ablation depth per pulse : $\Delta h \leq \max(l_T, l_\alpha)$

with

the heat penetration depth l_T :

$$l_T \approx 2\sqrt{D\tau_l}$$

including the laser pulse length τ_l

and the thermal diffusivity $D = \kappa/(\rho c_p)$

$$D_{metals} = 0.1 - 2 \text{ [cm}^2/\text{s}]$$

$$D_{oxides} = 0.01 - 1 \text{ [cm}^2/\text{s}]$$

$$D_{polymers} = 0.001 - 0.01 \text{ [cm}^2/\text{s}]$$

the light penetration depth l_α :

$$l_\alpha = \alpha^{-1}$$

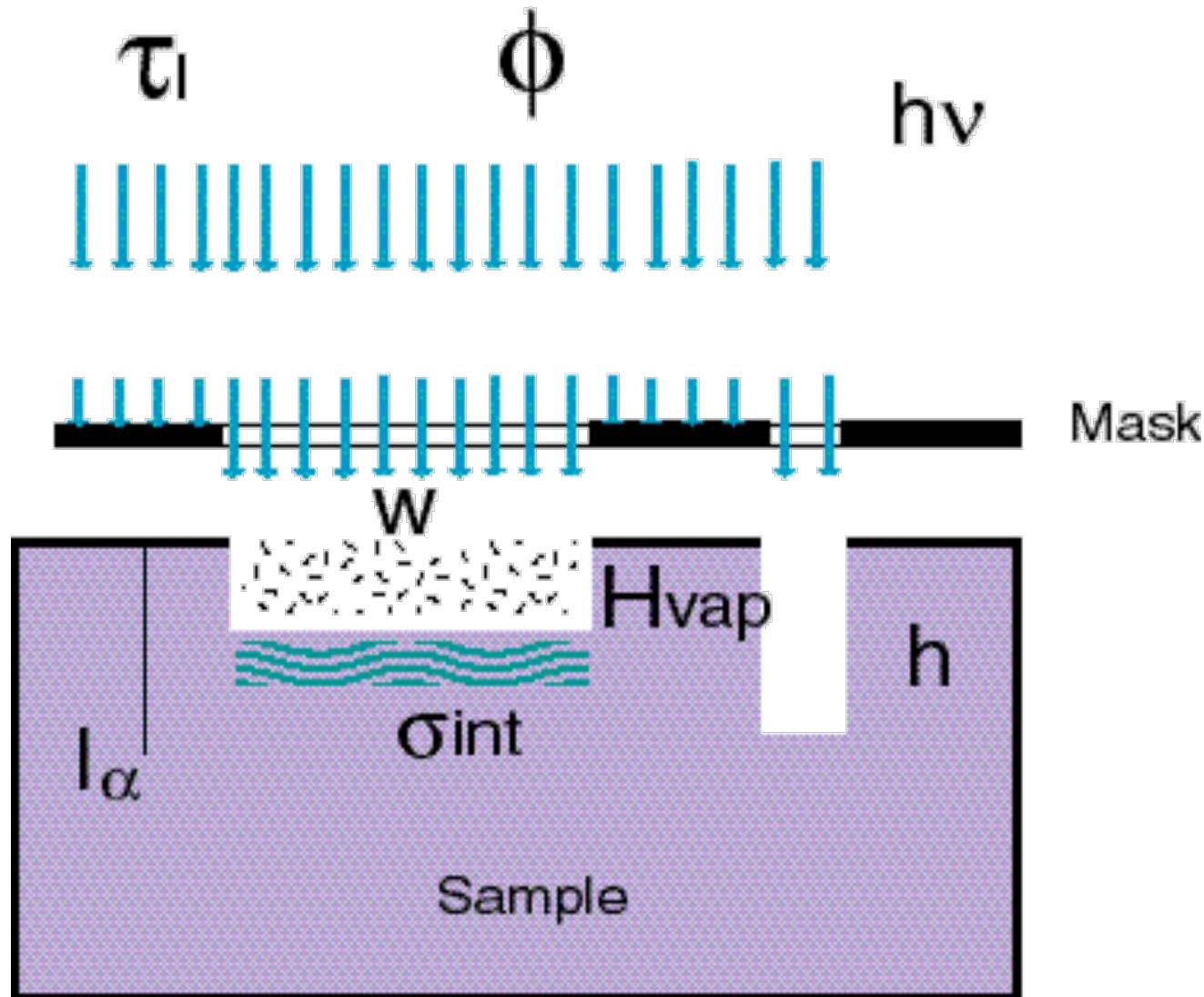
Is Cold Laser Processing possible ?

High vacuum molecule photon interactions:
Excitation by absorption – thermal relaxation
(10^{-14} – 10^{-6} s) useful for isotope separation,
polyatomic molecules, (10^{-13} – 10^{-11} s)

Generally in liquids and solids:
Excitation by absorption – thermal relaxation τ_T
Metals & Semicond. (el-el) 10^{-14} - 10^{-13} s ; (el-phon) 10^{-12} - 10^{-6} s

Check thermal effects: The heat equation

Ablation – complex phenomenon



Excimer Laser model

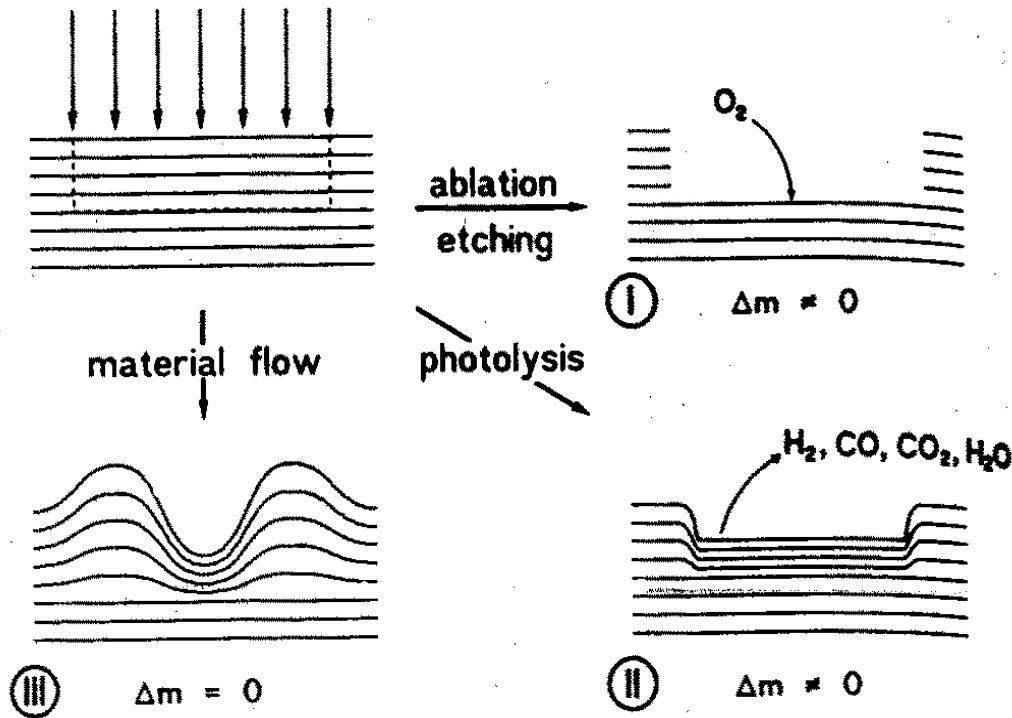
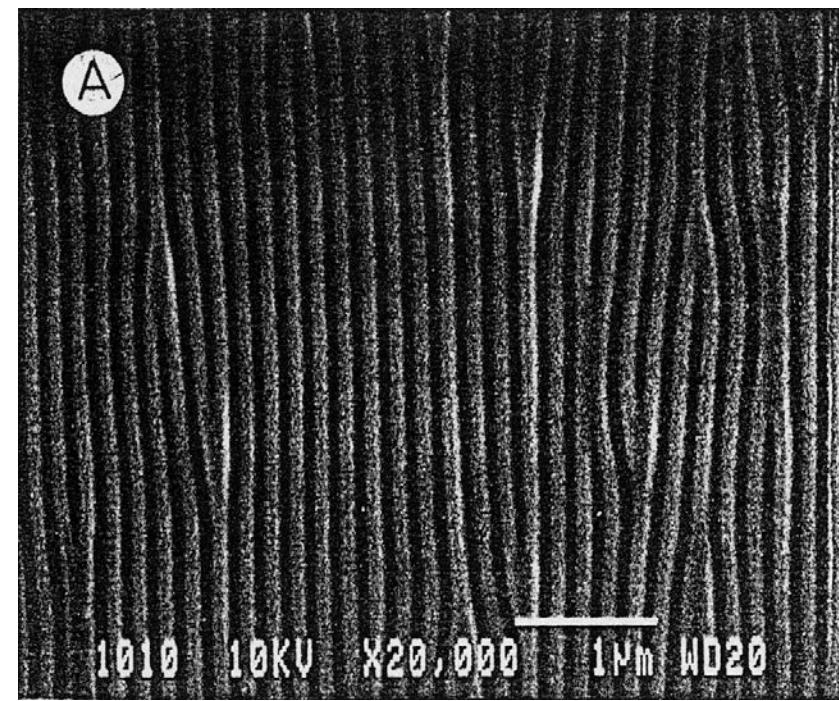


FIG. 13. Three models of photoactivated surface corrugation; (I) ablation or etching; (II) photolysis; (III) is material flow. Processes I and II are accompanied with mass decrease, even in vacuum, whereas III operates at constant mass.



Ceramics Ablation Examples

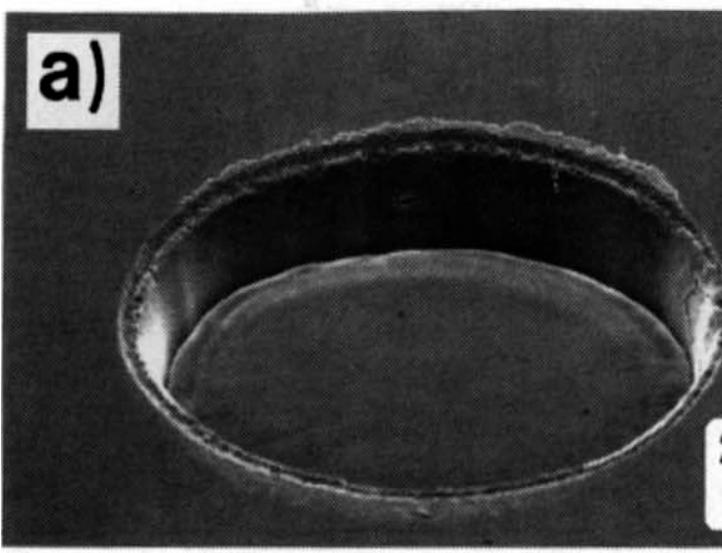
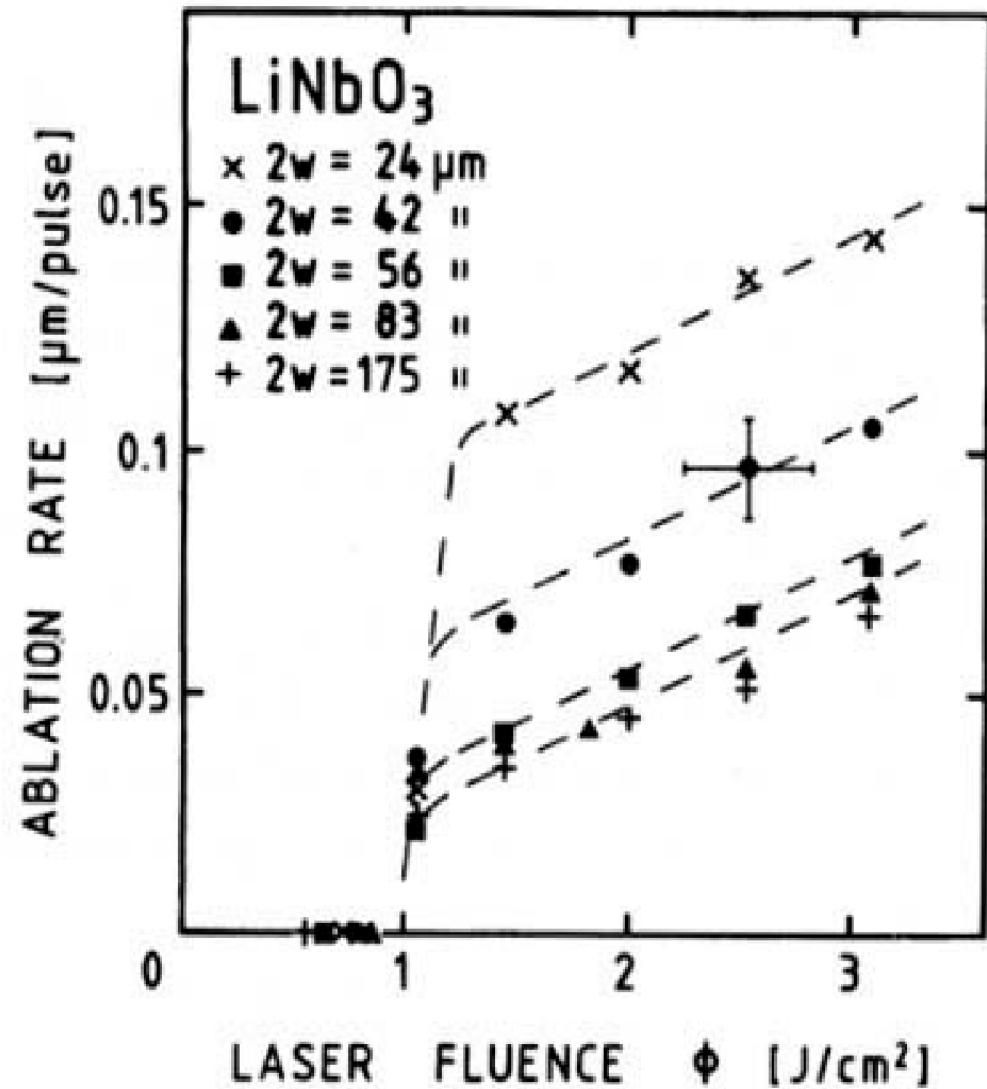
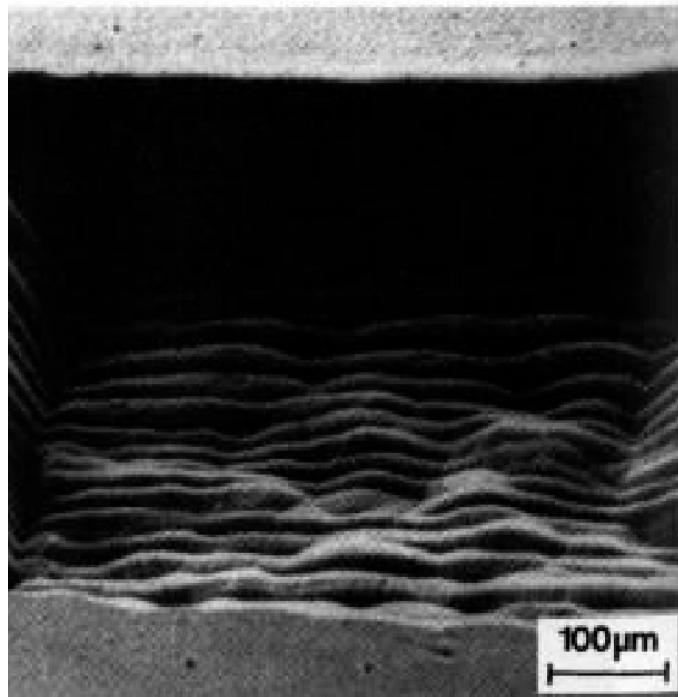
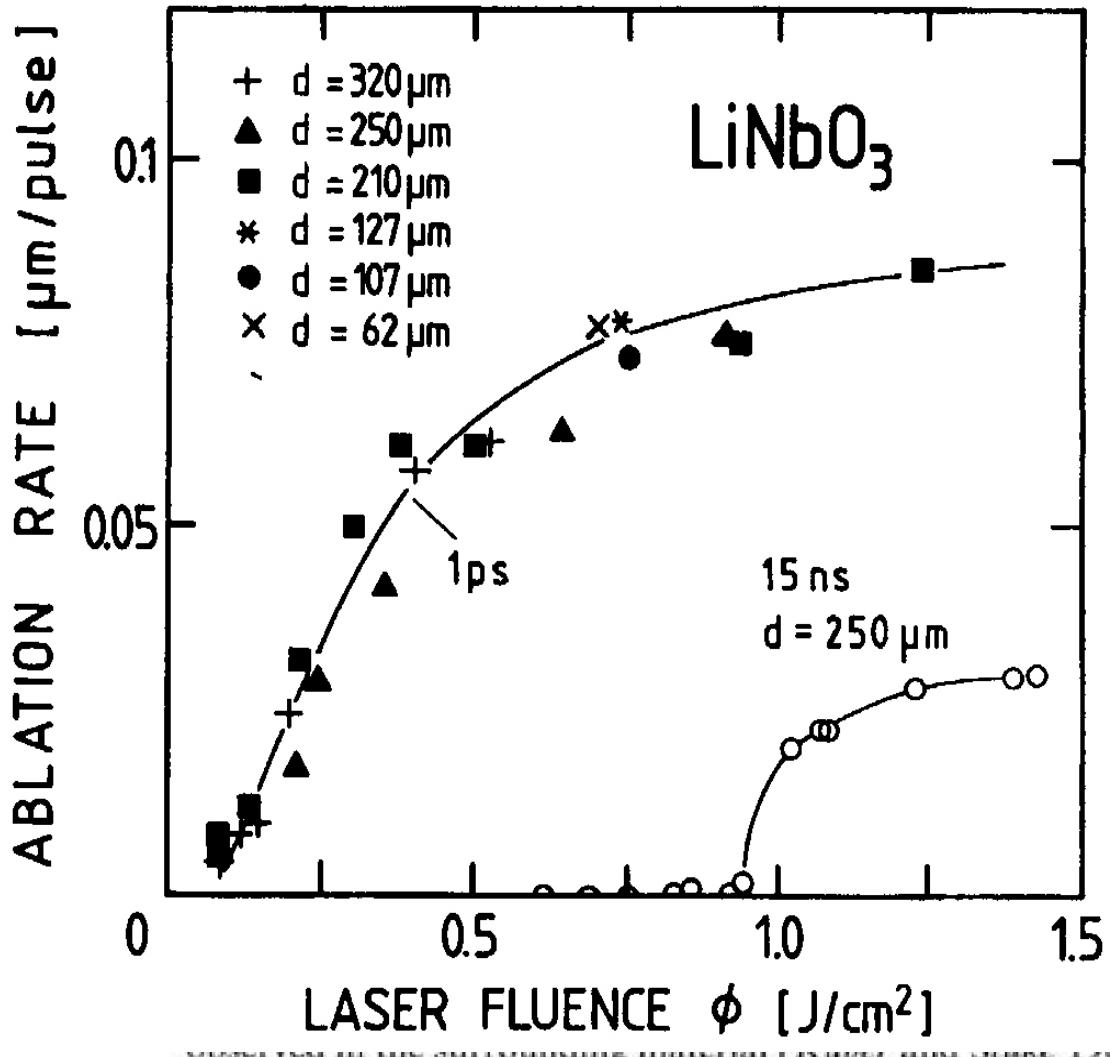


Fig. 12.1.2a,b. Projection patterning by ($\lambda = 308 \text{ nm}$, $\phi = 2.7 \text{ J/cm}^2$, $2w = 175 \mu\text{m}$) $\text{YBa}_2\text{Cu}_3\text{O}_7$ film on (100) SrTiO_3 sub [Heitz et al. 1990]



Ablation Influences



48 nm KrF-laser radiation. (a) Irradiation ($\phi = 4.2 \text{ J/cm}^2$). An undefined crater is material. (b) Irradiation with fs pulses relatively smooth and no cracks are visible.